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S

2500 PCS

Go

ID	R <sub>DS</sub> (ON)(Typ)	VDSS
4A	2Ω	650V

#### **Applications:**

- Switch Mode Power Supply(SMPS)
- Adapter & Charger
- AC-DC Switching Power Supply

#### **Features:**

- Fast swi
- 100% av
- Improve

#### Ordering

RS4N65D

Fast switching spee 100% avalanche te mproved dv/dt cap	sted pability		RoHS	EACH HF
dering Information	1			
Part Number	Package	Marking	Packing	Qty.

RS4N65D

D

Tape&reel

## Absolute Maximun Ratings Tc= 25°C unless otherwise specified

T0-252

Symbol	Parameter	RS4N65D	Units			
VDSS	Drain-to-Source Voltage	650	V			
ID	Continuous Drain Current TC=25℃	Current TC=25°C 4				
IDM	Pulsed Drain Current (Note*1)	16	A			
PD	Power Dissipation	107	W			
VGS	Gate- to- Source Voltage	±30	V			
EAS	Single Pulse Avalanche Engergy L = 10mH, VDD = 50V, RG = 25 Ω	80	mJ			
TL TPKG	Maximum Temperature for Soldering Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds	300 260	°C			
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150				

\* Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the" Absolute Maximum Ratings" Table may cause permanent damage to the device.



# **Thermal Resistance**

Symbol	Parameter	RS4N65D	Units	Test Conditions	
				Drain lead soldered to water cooled	
RθJC	Junction-to-Case	1.16		heatsink, PD adjusted for a peak	
			°C/W	junction temperature of + 1 5 0 $^\circ \! \mathbb{C}$	
DOLA	Junction-to-	00		1 auhia fa at ah amh an fuas air	
RθJA	Ambient	80		1 cubic foot chamber,free air.	

# **OFF Characteristics** TJ= $25^{\circ}$ C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVDSS	Drain- to- source Breakdown Voltage V		VGS=0V,ID=250µA			
IDSS	Drain- to- Source Leakage Current			1	μA	VDS=650V,VGS=0 V
	Gate- to- Source Forward Leakage			100	_	VGS=30V,VDS=0V
IGSS	Gate- to- Source Reverse Leakage			-100	nA	VGS=-30V ,VDS=0 V

# **ON Characteristics** TJ=25°C unless otherwise specified

Symbol	Parameter		Тур.	Max.	Units	Test Conditions
RDS(on)	Static Drain- to- Source On- Resistance(Note*2)		2	2.4	Ω	VGS=10V,ID=2A
VGS(TH)	Gate Threshold Voltage	3		4	V	VGS=VDS,ID=250µ A

# Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter		Тур.	Max.	Units	Test Conditions	
td(ON)	Turn- on Delay Time		36				
trise	Rise Time		13			VDS=325V	
td(OFF)	Turn- OFF Delay Time		80		nS	ID=4A RG=25Ω	
tfall	Fall Time		24				
tfall	Fall Time		24				



Dynamic Characteristics	Eccentially independent	ent of operating temperature
Dynamic Characteristics	Losennany mucpenue	in or operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions	
Ciss			543			VGS=0V	
Coss			53		pF	VDS=25V	
Crss	Reverse Transfer Capacitance		4.5			f=1.0MHz	
Qg	Total Gate Charge		15			VDS=520V	
Qgs	gs Gate- to- Source Charge		3		nC	ID=4A	
Qgd	Gate-to-Drain(" Miller") Charge		7			VGS=10V	

## Source- Drain Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions	
IS	Continuous Source Current			4	А	Integral pn- diode	
ISM	Maximum Pulsed Current			16	А	in MOSFET	
VSD	Diode Forward Voltage			1.4	V	IS=2A,VGS=0V	
trr	Reverse Recovery Time		550		nS	VGS=0V	
Qrr	Reverse Recovery Charge		1.38		μC	IS=2A,di/dt=100A/ µs	

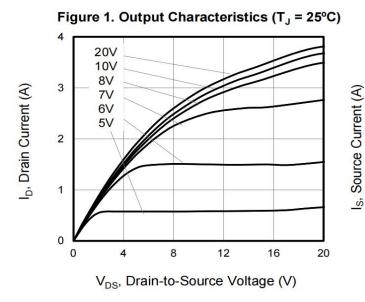
#### Notes:

\* 1. Repetitive rating, pulse width limited by maximum junction temperature.

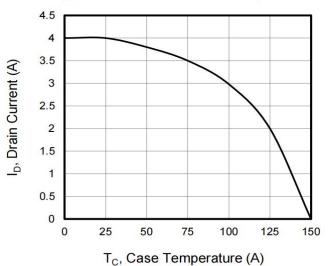
\* 2. Pulse Test: Pulse width  $\leq$  300µs, Duty Cycle  $\leq$  1%

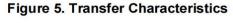


#### **Typical Feature Curve**









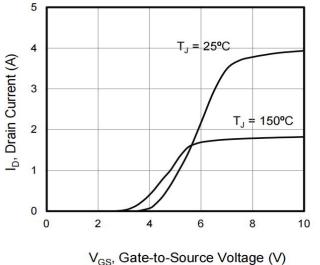
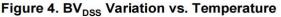


Figure 2. Body Diode Forward Voltage  $10^{1}$   $10^{0}$   $10^{-1}$   $10^{-2}$  0.2 0.4 0.6 0.8 1 1.2V<sub>SD</sub>, Source-to-Drain Voltage (V)



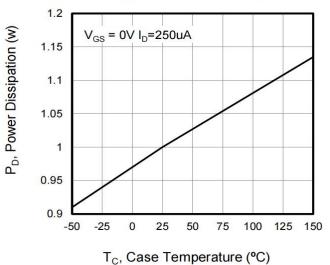
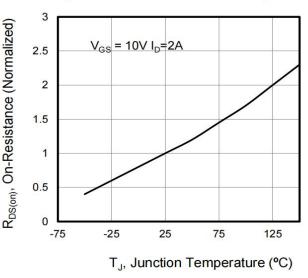
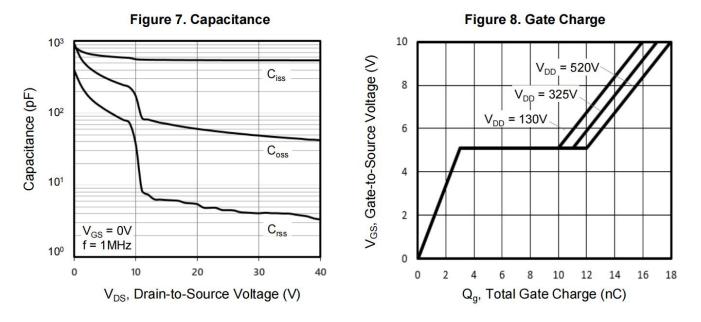


Figure 6. On-Resistance vs. Temperature

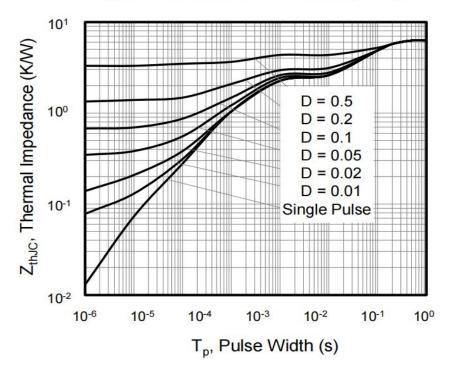


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### **Test Circuits and Waveforms**

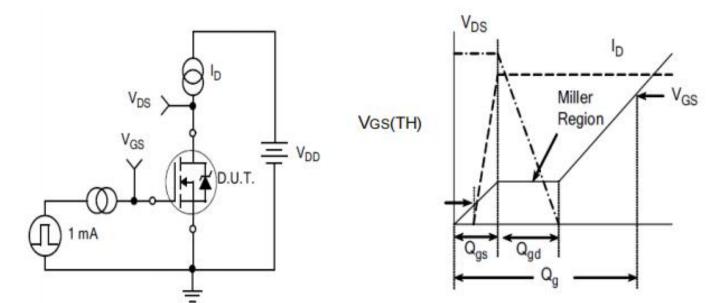
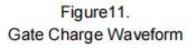


Figure10. Gate Charge Test Circuit



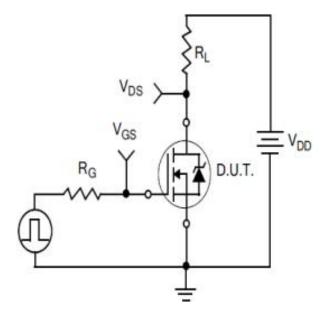


Figure12. Resistive Switching Test Circuit

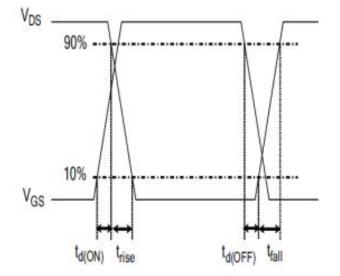


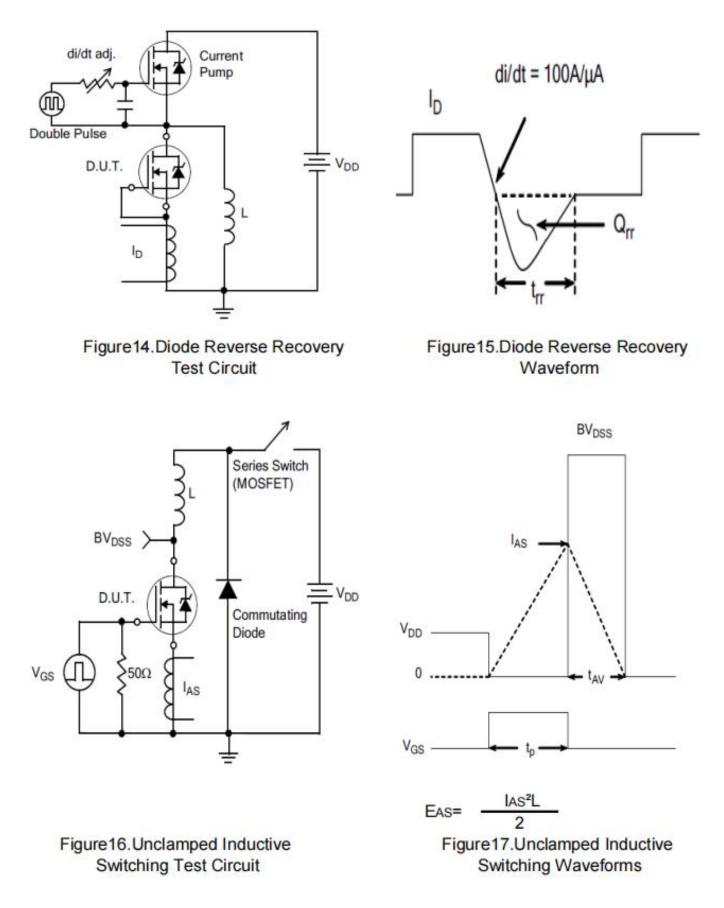
Figure13. Resistive Switching Waveforms

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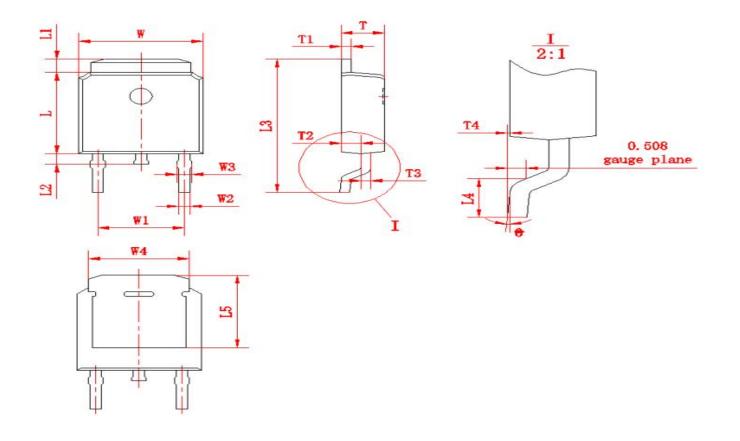


## Test Circuits and Waveforms





# Package outline drawing(TO-252 Unit: mm)



符号	尺	<b>寸</b>	符号	F	रे	符号	尺寸	
17 7	Min	Max	¢ 1/1	Min	Max	ב נו	Min	Max
W	6.50	6.70	L1	0.80	1.20	T1	0.48	0.58
W1	(4.5	572)	L2	0.60 1.00		T2	0.95	1.15
W2	0.6	0.8	L3	9.70	10.30	Т3	0.48	0.58
W3	0.68	0.88	L4	1.30	1.70	T4	0.00	0.12
W4	(5	.3)	L5	(5.20)		0	0	8
L	6.00	6.20	Т	2.20	2.40			



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